


<b>Search Notes</b>  	<b>Application/Control No.</b>  10540374	<b>Applicant(s)/Patent Under Reexamination</b>  MOCHI ET AL.
	<b>Examiner</b>  HYUN PARK	<b>Art Unit</b>  2863

SEARCHED			
Class	Subclass	Date	Examiner
702	23	07/24/2009	HP

SEARCH NOTES		
Search Notes	Date	Examiner
consulted the examiner Moffat, class 702	07/24/2009	HP
consulted 101 panel, TC 2800	07/24/2009	HP
text search combined with the following subclass 702/24, 30-32, 34, and 182	07/24/2009	HP
consulted examiner Kundu, class 702	01/11/2010	HP

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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